## Notic of References Cit d Application/Control No. O9/901,979 Applicant(s)/Patent Under Reexamination HEUER ET AL. Examiner Art Unit Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
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	С	US-			
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	G	US-			
	н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP-393746	10-1990	EP	Valcke et al	
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## NON-PATENT DOCUMENTS

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